

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

216353US2

SERIAL NO.

09/988,555

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yuji ABURAKAWA, et al.

FILING DATE

November 20, 2001

GROUP

2681

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>SK</i>	AA	5,404,572	04/04/1995	D. ISHII	—	—	
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>SK</i>	AO	11-220441	08/10/1999	JAPAN (with English Abstract)		X
<i>SK</i>	AP	2000-357997	12/26/2000	JAPAN (with English Abstract)		X
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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☐ Additional References sheet(s) attached

Examiner

SK:LG

Date Considered 8/1/2005

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

216353US8

SERIAL NO.

09/988,555

LIST OF REFERENCES CITED BY APPLICANT

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FILING DATE

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GROUP

2681

U.S. PATENT DOCUMENTS

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JAN 23 2004

Technology Center 2600

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
Sh	AO	20-0180276	05/01/2000	KOREA (with corr. WO 01/35551)		X
Sh	AP	WO 01/35551	05/17/2001	WIPO		
Sh	AQ	1996-27492	07/22/1996	KOREA (with partial English translation)		
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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☐ Additional References sheet(s) attached

Examiner

SLK:LS

Date Considered

8/1/05

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 216353US90		SERIAL NO. 09/988,555	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yuji ABURAKAWA, et al.			
				FILING DATE November 20, 2001		GROUP 2681	

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MAR 30 2004
PATENT & TRADEMARK OFFICE

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
AK	AA	5,844,705	12/01/1998	C. L. RUTLEDGE			
AK	AB	5,748,623	05/05/1998	M. SAWAHASHI, et al.			
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Technology Center 2600

FOREIGN PATENT DOCUMENTS						
DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION			
			YES	NO		
AK	AO	1190828	08/19/1998	THE PEOPLE'S REPUBLIC OF CHINA (with corr. US 5,844,705)		
AK	AP	1115195	01/17/1996	THE PEOPLE'S REPUBLIC OF CHINA (with corr. US 5,748,623)		
AK	AQ	44 33 896	11/09/1995	GERMANY		
AK	AR	1451210	10/22/2003	THE PEOPLE'S REPUBLIC OF CHINA (with corr. WO 01/52450)		
AK	AS	WO 01/52450	07/19/2001	WIPO		
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)	
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Examiner <i>SKL</i>	Date Considered <i>8/1/05</i>
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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

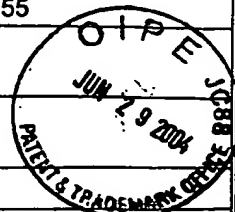
Yuji ABURAKAWA, et al.

FILING DATE

November 20, 2001

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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>sk</i>	AO	6-77350	10/28/1994	JAPAN (with English Abstract)		X
<i>sk</i>	AP	10-285114	10/23/1998	JAPAN (with English Abstract)		X
<i>sk</i>	AQ	10-107685	04/24/1998	JAPAN (with English Abstract)		X
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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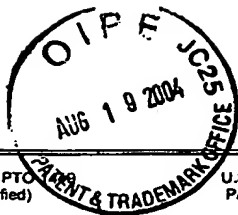
Examiner

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>sk</i>	AO	10-0350470	08/16/2002	KOREA (with partial English translation)		
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FOREIGN PATENT DOCUMENTS

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					YES	NO
<i>SR</i>	AO	2000-295181	10/20/2000	JAPAN (with English Abstract)		X
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>sk</i>	AO	1-151328	06/14/1989	JAPAN (with English Abstract)			X
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Examiner <i>SKG</i>					Date Considered <i>8/1/05</i>		
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